für Bildung und Forschung Experience from design, prototyping and production of a **RNITHAACHEN** UNIVERSITY **DC-DC conversion powering scheme for the CMS Phase-1 Pixel Upgrade** L. Feld, W. Karpinski, K. Klein, M. Lipinski, M. Preuten, M. Rauch, S. Schmitz and M. Wlochal, for the CMS Collaboration TWEPP 2015 – Topical Workshop on Electronics for Particle Physics, 28.9. - 3.10.2015, Lisbon, Portugal

+Z side x2F3

The CMS Phase-1 Pixel Upgrade

- Present pixel detector was designed for 1.0 x 10³⁴ cm⁻² s⁻¹, would suffer from inefficiency for higher instantaneous luminosities
- Upgrade during an extended technical stop 2016/2017 [1]
- Additional layers \rightarrow factor 1.9 more channels \rightarrow factor 1.9 higher currents \rightarrow factor 3.6 larger losses on supply cables
- A DC-DC conversion powering scheme allows to power the detector with the legacy cable plant and power supplies





The Powering Scheme and its Implementation



 DC-DC converters installed at 1-2m distance of the pixel modules, on support structures • Pseudorapidity ~ 4, outside tracking volume 1200 DC-DC converters in total

- Converters deliver low voltages to the readout chip:
- 2.4V for the analogue part
- 3.3V and 3.5V for the digital part
- One pair powers 1 to 4 pixel modules (1-2A)





The DC-DC Buck Converters for the CMS Phase-1 Pixel Detector

• A = $2.8 \times 1.7 \text{ cm}^2$ • m = 3.0g • 2-layer PCB

 Radiation-tolerant FEAST2 ASIC [2] by CERN • Enable feature • Status bit "Power good" Protection features

• Switching frequency set to 1.5MHz

 Toroidal inductor • L ≈ 430nH

• To be soldered by hand

• **SMD components** for noise filtering, voltage divider etc. Smallest size: 0201

• Electro-magnetic shield: plastic core with 60µm copper outside • Filled with thermal grease • To be soldered by hand • Shorts with SMD components to be avoided

Several years of R&D and prototyping [3].





Production Steps, Quality Assurance & Control

- Production of the PCBs → optical inspection • Production of coils in China; sorted into inductance classes
- Production of shields in Germany
- · Assembly at a company, including hand-soldering of the coil and shield Automated Optical Inspection
 - High-resolution X-ray imaging of all samples
 - 10 passive thermal cycles between -30°C and +60°C
- Electrical test (output voltage, status bit, enabling) Done twice: before and after shield mounting • Micrographs of a few samples
- Thermal cycling: 10 cycles between -28°C and +20°C Converters are powered and deliver I_{out} = 3A • Monitoring of voltage, status bit and temperature • 16 DC-DC converters per test, duration ≈ 10 hours • Throughput ≈ 80 DC-DC converters per week







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Issues during Pre-Production & Production

Solder deposition failed during a pre-production run

- Spotted only during thermal cycling, e.g. due to converters switching off after several cycles
- Not spotted by low resolution X-ray test, nor optical inspection
- \rightarrow change of assembly company, and assembly of production boards according to IPC-A-610D (Class 3)

Voids in solder of 0201 SMD components

- Spotted in micrographs
- Not spotted in X-ray images, since originally passives only X-rayed in 10% of samples
- Caused by bad resistor quality
- \rightarrow Resistor producer changed, and X-ray test of full boards performed on 100% of samples



Electro-mechanical Integration: DC-DC Bus Boards

• Distribution of input and output voltages, status and enable signals 13 pairs of DC-DC converters per motherboard → dense 8 layer PCB



• Up to 2W of heat load per DC-DC converter, to be removed by the CO₂ cooling system • Two-piece aluminium cooling bridges; lower pieces glued to the DC-DC bus boards (520 pieces)



- 1800 DC-DC converters have been produced
- 1200 DC-DC converters fully tested so far yield is 87%
- Vast majority: faulty status output of the (non-tested) ASIC Only 8 DC-DC converters with other problems
- (short in chip, V_{out} very low/zero, very high or unstable)
- 24% of faults have been found during thermal cycling! • Efficiency $\eta = P_{out} / P_{in}$ is high and uniform
- Spread in output voltage is $\sigma \approx 35\text{-}50\text{mV}$
- \rightarrow converters are classified by output voltage





A Challenging System Feature: Large, Load-dependent Voltage Drops

- DC-DC converters do not feature remote sensing; output voltage is regulated locally, and cannot be adjusted in-situ
- DC-DC output voltages must be carefully chosen: too low \rightarrow pixel modules will not work; too high \rightarrow risk of damage for zero load
- Up to 2m distance between DC-DC converters and pixel modules -> large, load-dependent voltage drops have to be precisely known and taken into account
- In addition:
 - Spread of output voltage: $1\sigma \approx 35-50mV$
- Bridges need to be anodized to isolate the converters from the grounded pipes (avoid ground loops)

Step 1: Lower pieces are precisely aligned with respect to connectors, and glued to the bus boards



Step 2: During installation, CO₂ pipes are layed in

Step 3: Upper pieces are screwed to lower pieces



Step 4: DC-DC converters are screwed onto bridges



A fully equipped bus board



- Load regulation: up to -10mV/A
- Temperature variation: $\approx 0.7 \text{mV/K} \rightarrow \Delta \text{V} = 28 \text{mV}$
- Irradiation effects for expected dose of 100kGy and fluence of 2 x 10^{14} n_{ed}/cm²: $\Delta V \approx 30$ mV



Next Steps

- Mass production of DC-DC converters until November 2015. Power board production finished.
- Installation of boards and DC-DC converters into the pixel support structures starts December 2015 • Installation in CMS during extended winter technical stop 2016/2017

References

[1] CMS Collaboration, CMS Technical Design Report for the Pixel Detector Upgrade, CERN-LHCC-2012-016 (2012). [2] http://project-dcdc.web.cern.ch/project-dcdc/ [3] L. Feld, W. Karpinski et al., The DC-DC conversion power system of the CMS Phase-1 pixel upgrade, 2015 JINST 10 C01052.



Low mass module cable (1m)

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